

Application of NDE Simulations to Estimate Probability of Detection

**Joe Gray, Irving Gray
NDE Technologies, Inc.
Charlottesville, Virginia**

Components of Probability of Detection

- **Equipment variability**

 - inherent filtration of x-ray tube

 - eddy current lift off and coil tilt

 - broad band center frequency

- **Setup variability**

 - placement of the central axis of the x-ray tube

 - orientation of the UT probe

 - scan variation in lift off and probe tilt

- **Signal Noise**

- **Flaw morphology effects**

 - size

 - shape

 - position in the part

 - orientation in the part

- **Visual acuity – human variability of the eye**

 - cracks

 - pores

 - effects of complex images

- **Human factors**

 - mood

 - training

 - environment

Need for 2D Detectability criteria

Increased use of scanned data in inspections

X-ray, ultrasonics, eddy currents

1D scans

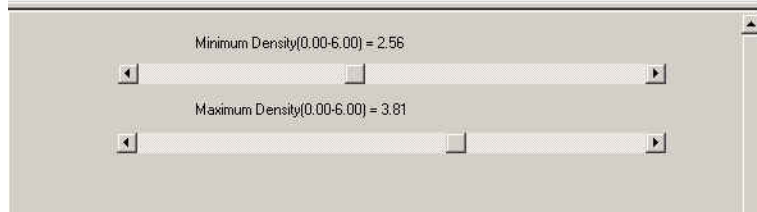
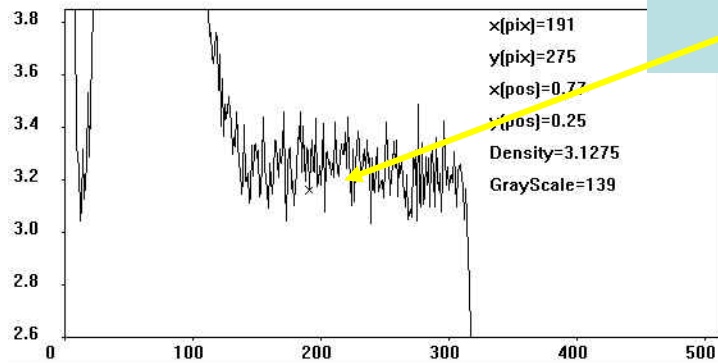
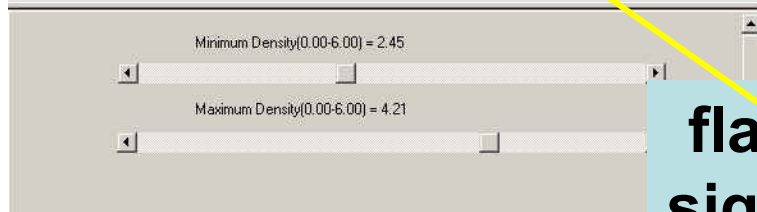
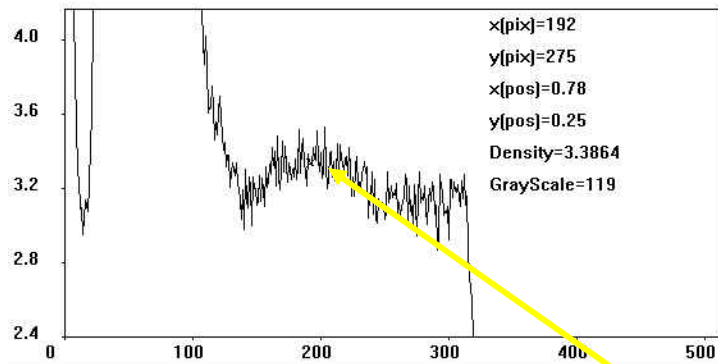
2D raster scans

2D imaging arrays

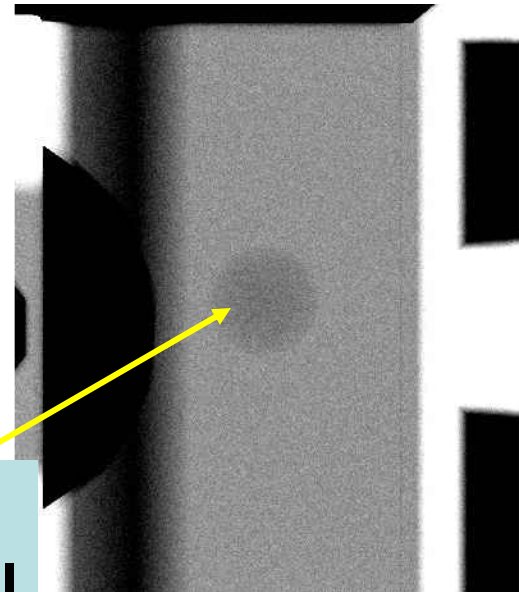
3D computed tomography

scans offer multiple measurements of a flaw

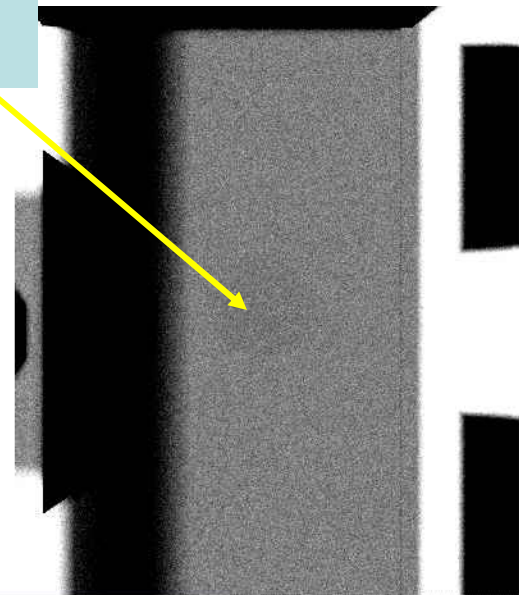
1D measurement



2D measurement



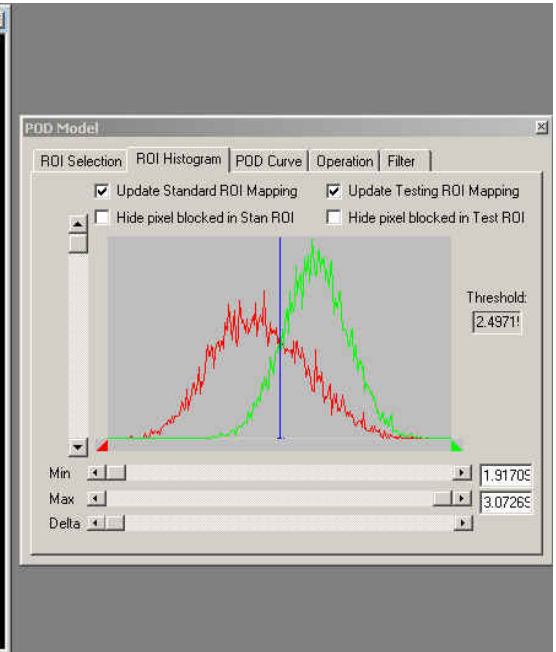
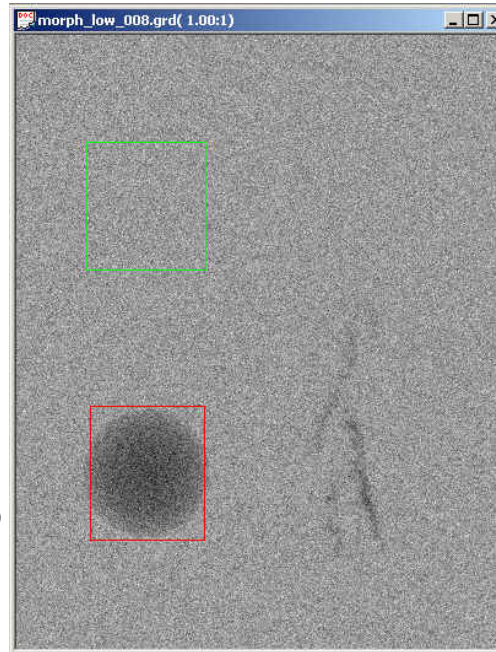
**flaw
signal**



2D Data Detectability

Both flaws are easily detected.

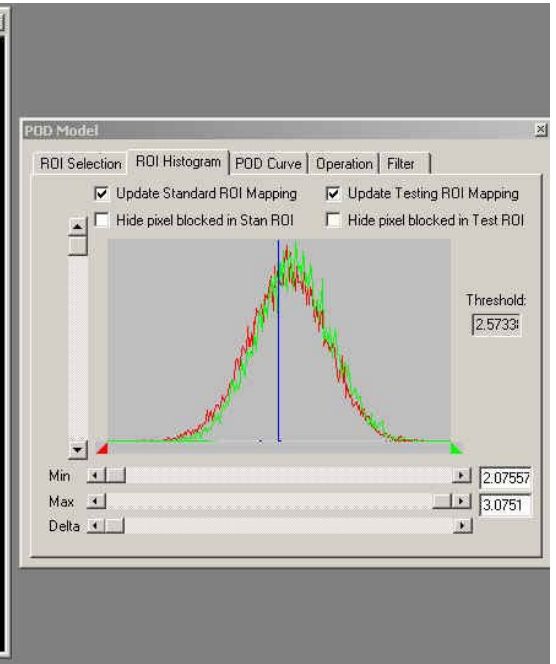
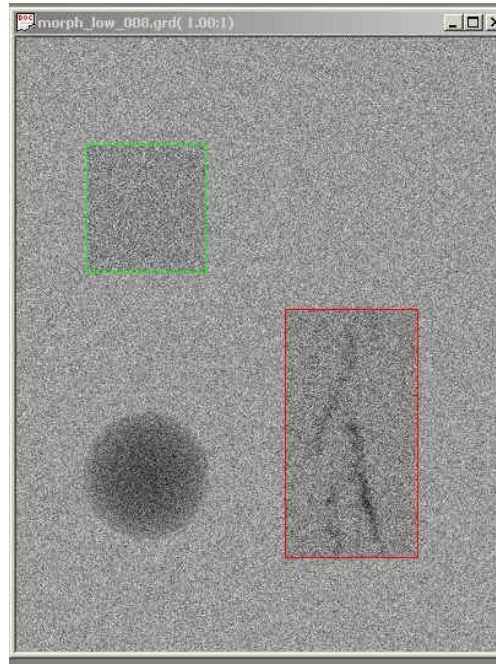
SNR=0.675



Signal to Noise Ratio

$$SNR = \frac{|D_{\text{background}} - D_{\text{flaw}}|}{\sigma}$$

SNR=0.298

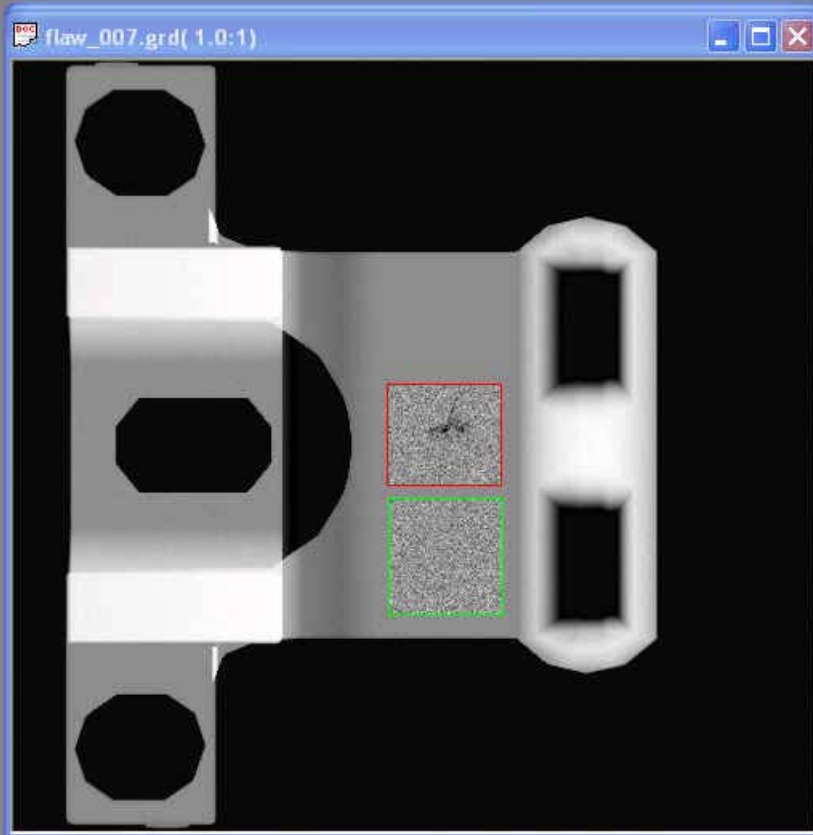


Automated Detectability Scans

binomial hypothesis test

- Given a signal mean and noise distribution
- What is the probability of a noise fluctuation producing the observed histogram of measured signals in the 2D area?
- Threshold for the test is a 5% false call

Large flaw



POD Model

ROI Selection | ROI Histogram | POD Curve | Operation | Filter

Standard Area				Testing Area			
	Select	Clear		Select	Clear		
Top:	272	Bottom: 345	Top:	201	Bottom: 264		
Left:	234	Right: 305	Left:	233	Right: 304		
Height:	73	Width: 71	Height:	63	Width: 71		
Minimum:	2.958	Maximum: 3.319	Minimum:	2.862	Maximum: 3.277		
Mean:	3.128	STD: 0.045	Mean:	3.124	STD: 0.049		

Low Intensity Defect Show Threshold

Result

Possibility of Detection (POD) is 99.7%.

Threshold = 3.069 Zt = 9.160

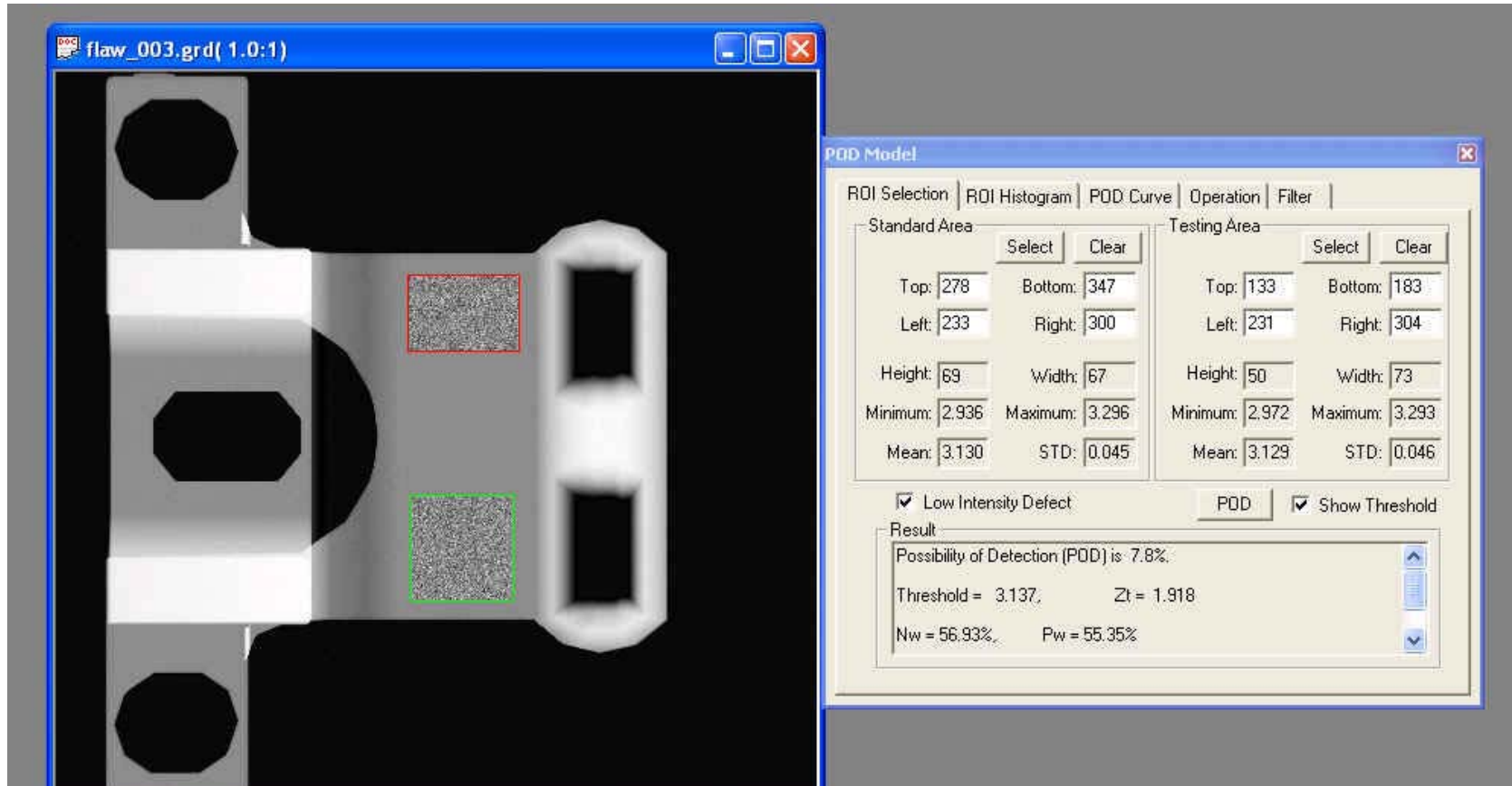
Nw = 12.63% Pw = 8.76%

Green region
standard

Red region
test area

Probability
99.7%

No flaw region

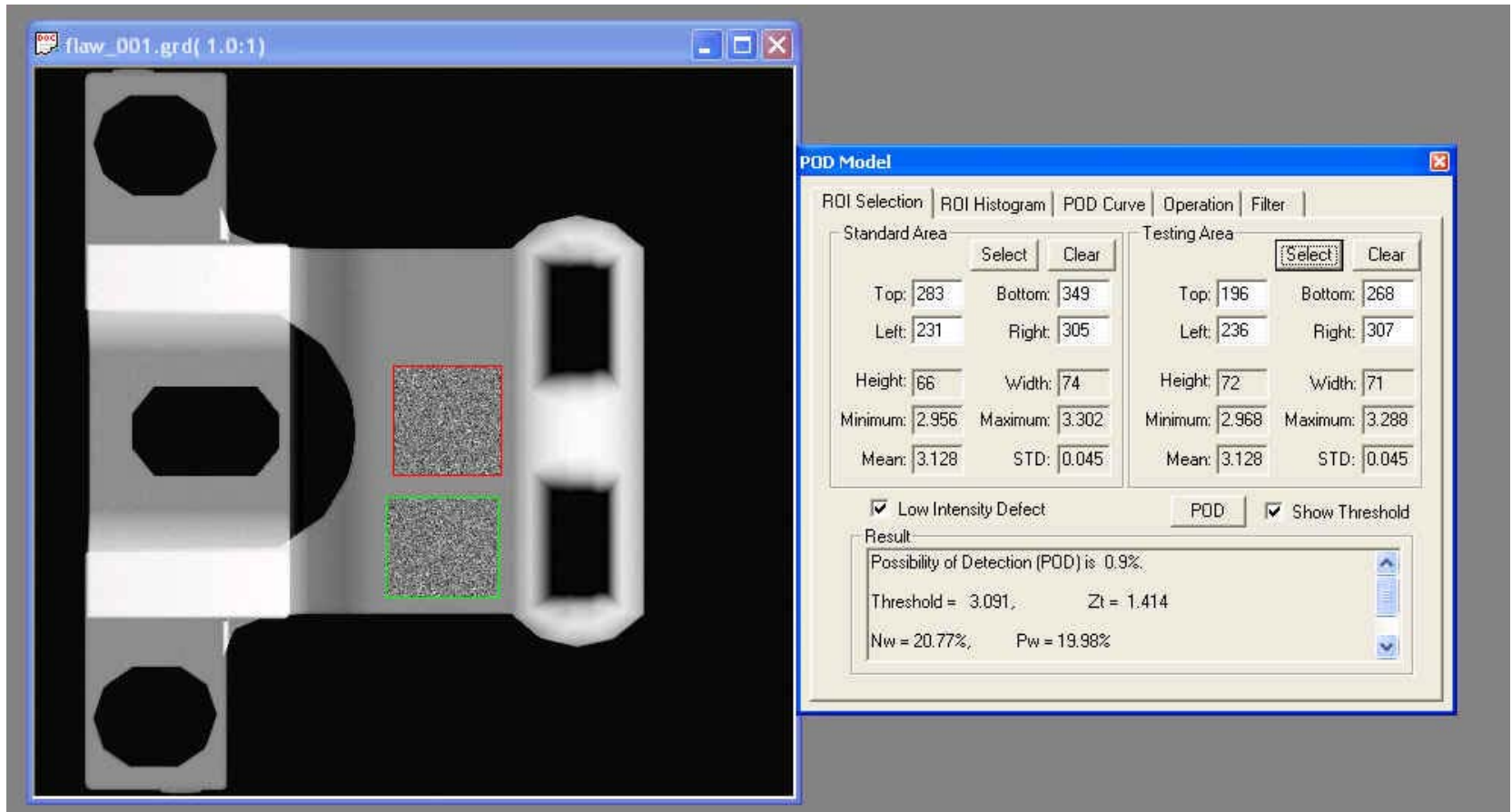


Green region
standard

Red region
test area

Probability
7.8%

Small flaw



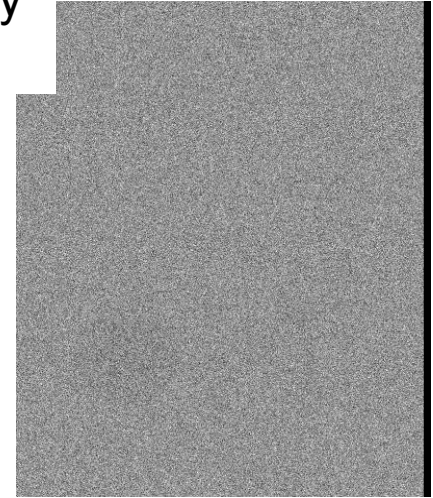
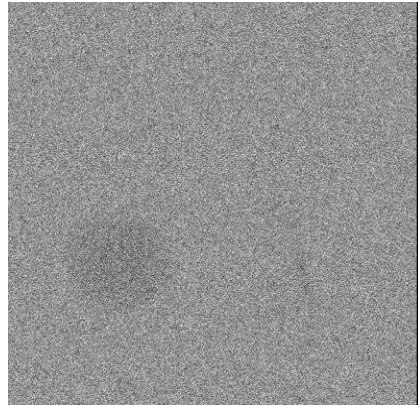
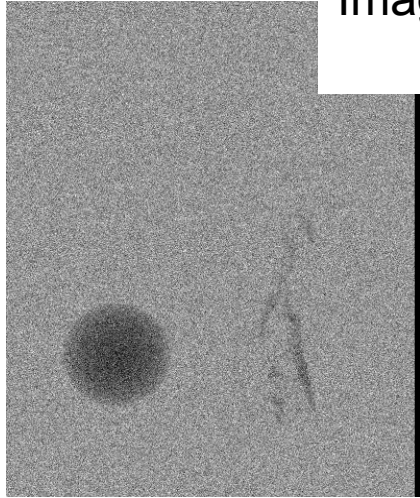
Green region
standard

Red region
test area

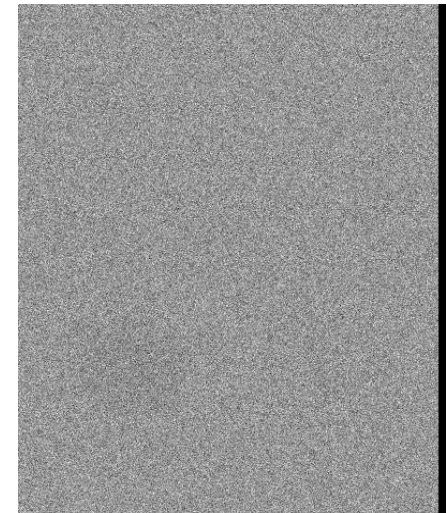
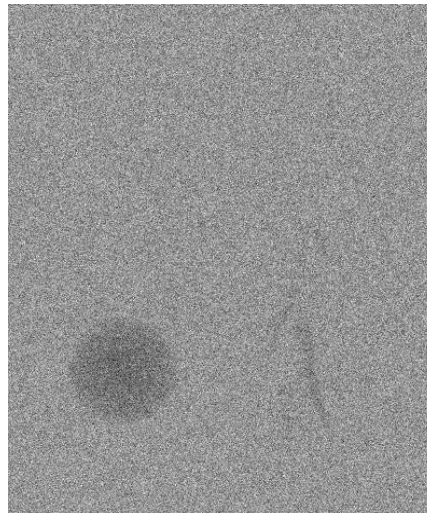
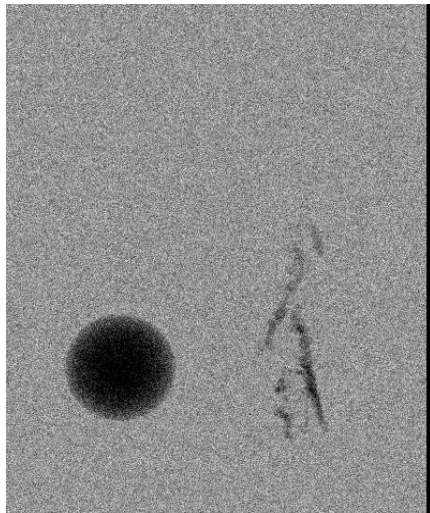
Probability
0.9%

Simple shapes versus real flaws

Images with different flaw morphology taken under with different kVP



High kVp



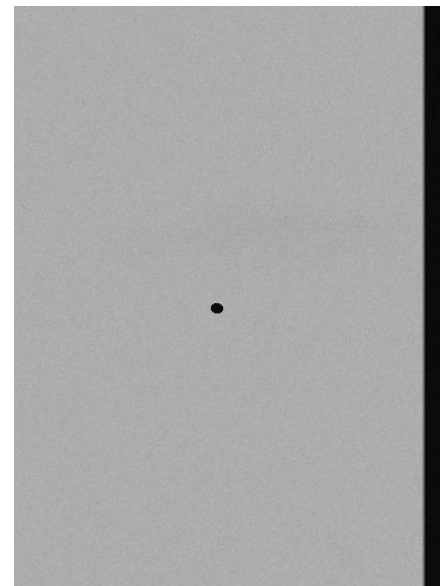
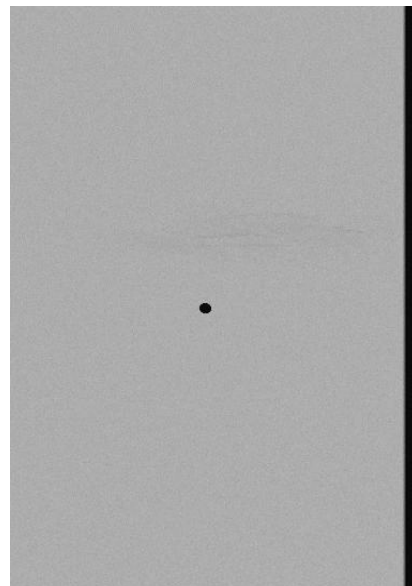
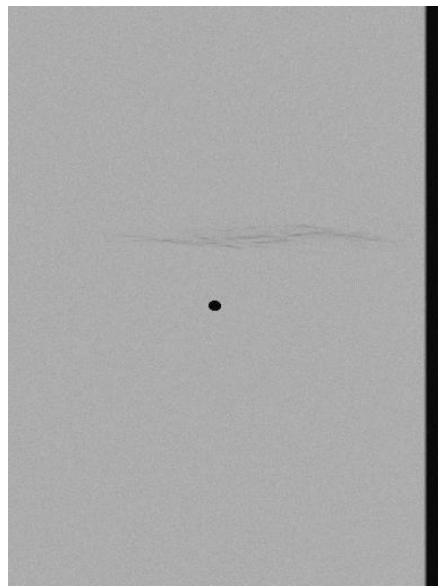
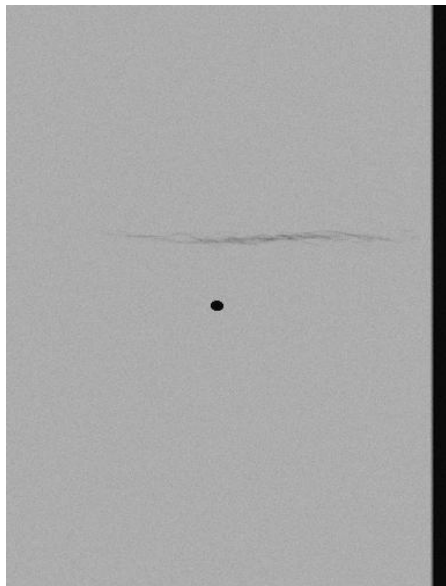
Large contrast

low kVp

Low contrast

Simple shapes versus real flaws

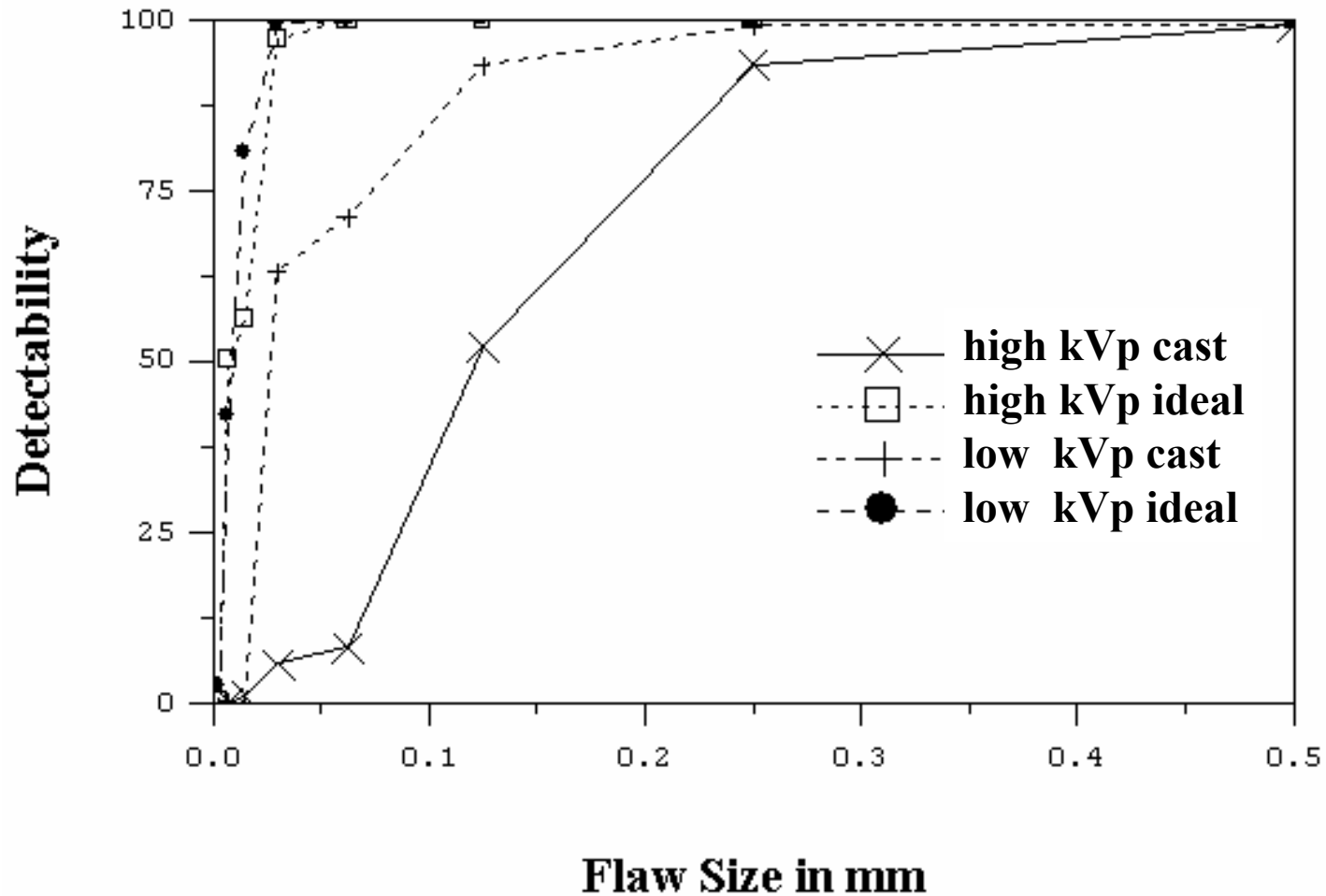
Effect of Defect Morphology on Signal
same crack size, different signal



optimal
orientation

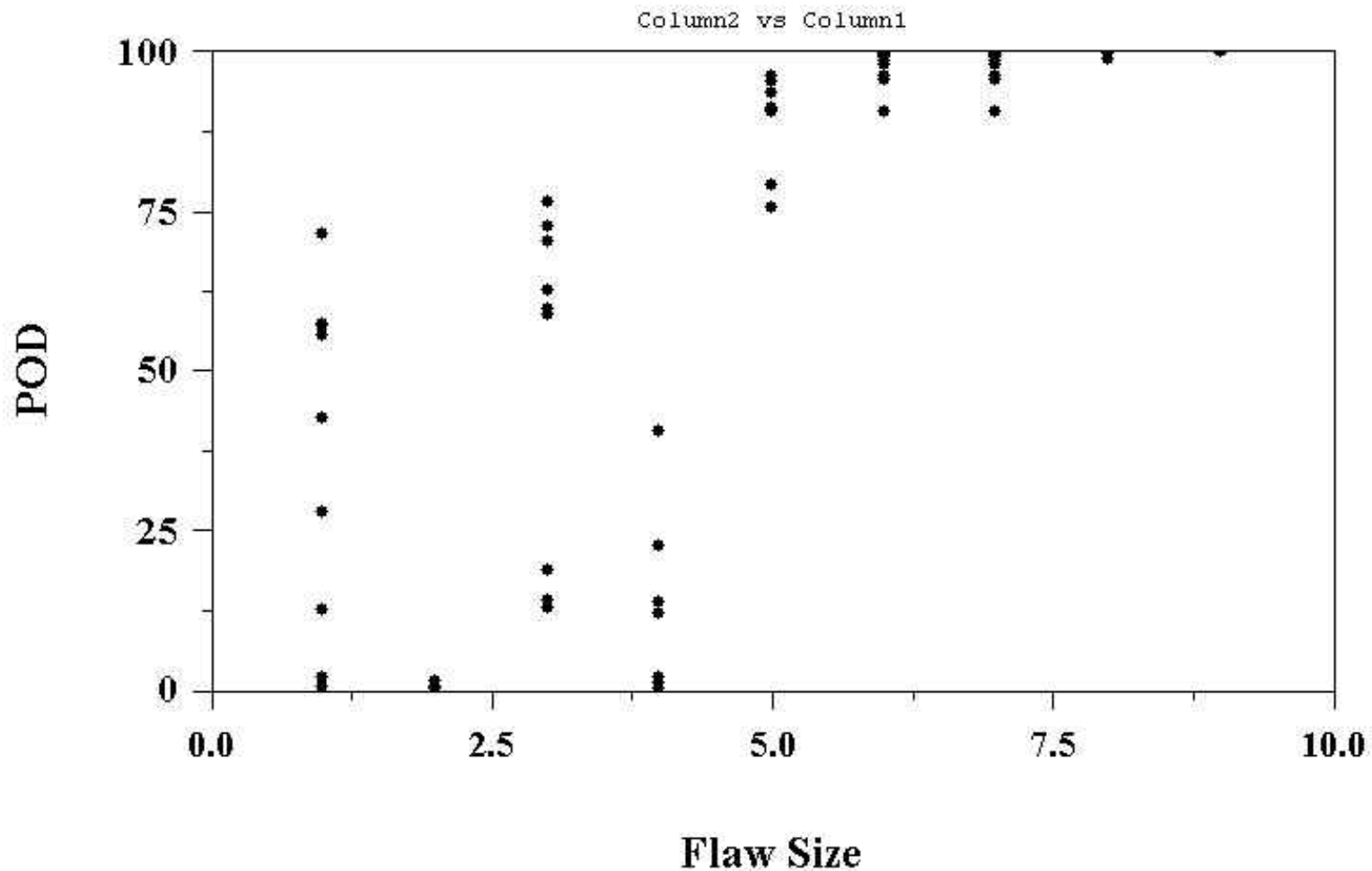
poor
orientation

Effect of Flaw Morphology and Kilovoltage on Detectability



Note: inclusion is not detectable

Effect of Flaw Morphology, Composition and Orientation



Conclusions

- **Detectability criteria for scan data**
- **Application of NDE simulations**
 - Simple shapes versus real flaws**